MOSFET – Power, Single, N-Channel, μCool, UDFN6, 2.0x2.0x0.55 mm 30 V, 6.1 A



- UDFN Package with Exposed Drain Pads for Excellent Thermal Conduction
- Low Profile UDFN 2.0 x 2.0 x 0.55 mm for Board Space Saving
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Battery Switch
- Power Load Switch
- DC-DC Converters

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain	Steady	$T_A = 25^{\circ}C$	I _D	6.1	А
Current (Note 1) Continuous Drain	State	T _A = 85°C		4.4	
Current (Note 1)	t ≤ 5 s	T _A = 25°C		9.3	
Power Dissipa- tion (Note 1)	Steady State	$T_A = 25^{\circ}C$	P _D	1.65	W
	$t \le 5 s$	$T_A = 25^{\circ}C$		3.8	
Continuous Drain	Steady	T _A = 25°C	Ι _D	3.8	А
Current (Note 2)	State	$T_A = 85^{\circ}C$		2.8	
Power Dissipation (Note 2)	$T_A = 25^{\circ}C$	PD	0.65	W
Pulsed Drain Current		tp = 10 μs	I _{DM}	19	А
MOSFET Operating Junction and Storage Temperature			T _J , T _{STG}	-55 to 150	°C
Source Current (Body Diode) (Note 1)			۱ _S	1.65	А
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C
0	M	D - 1 ¹			

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

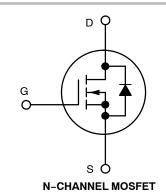
 Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm², 2 oz. Cu.

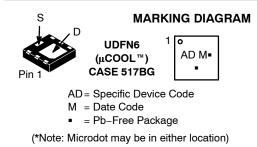


ON Semiconductor®

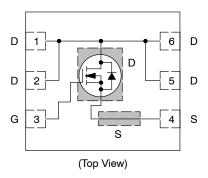
http://onsemi.com

MOSFET					
V _{(BR)DSS}	BR)DSS R _{DS(on)} MAX				
30 V	36 mΩ @ 4.5 V	6.1 A			
50 V	28.5 mΩ @ 10 V	5.5 A			





PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 3 of this data sheet.

^{1.} Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).

THERMAL RESISTANCE RATINGS

Parameter		Max	Unit
Junction-to-Ambient – Steady State (Note 3)	R_{\thetaJA}	75.7	
Junction-to-Ambient – t \leq 5 s (Note 3)		32.9	°C/W
Junction-to-Ambient – Steady State min Pad (Note 4)	R_{\thetaJA}	191.4	

Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm², 2 oz. Cu.

ELECTRICAL CHARACTERISTICS (T = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Units
OFF CHARACTERISTICS		-					
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 µA		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J	$I_D = 250 \ \mu A$, ref to $25^{\circ}C$			+16		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	$T_J = 25^{\circ}C$			1.0	μA
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V	V _{GS} = ±20 V			10	μA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, I _D = 250 μA	1.2	1.8	2.2	V
Negative Threshold Temp. Coefficient	V _{GS(TH)} /T _J				4.4		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	V, I _D = 6.1 A		19	28.5	mΩ
		V _{GS} = 4.5 V	V, I _D = 5.5 A	1	27	36	
Forward Transconductance	9FS	V _{DS} = 1.5 ^v	V, I _D = 6.0 A		16		S
CHARGES, CAPACITANCES & GATE	RESISTANCE						
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			476		pF
Output Capacitance	C _{OSS}				197		
Reverse Transfer Capacitance	C _{RSS}				100		
Total Gate Charge	Q _{G(TOT)}				4.8		nC
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V};$ $I_D = 5.5 \text{ A}$ $V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V};$ $I_D = 5.5 \text{ A}$			0.4		-
Gate-to-Source Charge	Q _{GS}				1.54		
Gate-to-Drain Charge	Q _{GD}				2.15		
	Q _{G(TOT)}				8.7		nC
SWITCHING CHARACTERISTICS, VG	S = 4.5 V (Note 6)			-		•	
Turn-On Delay Time	t _{d(ON)}				8.7		ns
Rise Time	t _r	Vcs = 4.5 V	Vpp = 15 V.		14.4		1
Turn-Off Delay Time	t _{d(OFF)}	V_{GS} = 4.5 V, V_{DD} = 15 V, I_{D} = 5.5 A, R_{G} = 3 Ω			9.1		1
Fall Time	t _f				3.3		
SWITCHING CHARACTERISTICS, VG	S = 10 V (Note 6)	•					
Turn-On Delay Time	t _{d(ON)}				4.1		ns
Rise Time	t _r	V_{GS} = 10 V, V_{DD} = 15 V, I_{D} = 6.1 A, R_{G} = 3 Ω			12.2		
Turn-Off Delay Time	t _{d(OFF)}				11.6	1	
Fall Time	t _f				2.2		
DRAIN-SOURCE DIODE CHARACTER	ISTICS	•		•			
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, T _J = 25°C			0.80	1.0	V
		$I_{\rm S} = 1.65 \text{A}$ $T_{\rm J} = 125^{\circ} \text{C}$		0.67			

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур	Max	Units
DRAIN-SOURCE DIODE CHARACTERISTICS						
Reverse Recovery Time	t _{RR}			14.6		ns
Charge Time	t _a	V _{GS} = 0 V, dls/dt = 100 A/μs, I _S = 3.3 A		6.8		
Discharge Time	t _b	I _S = 3.3 A		7.8		
Reverse Recovery Charge	Q _{RR}			5.4		nC

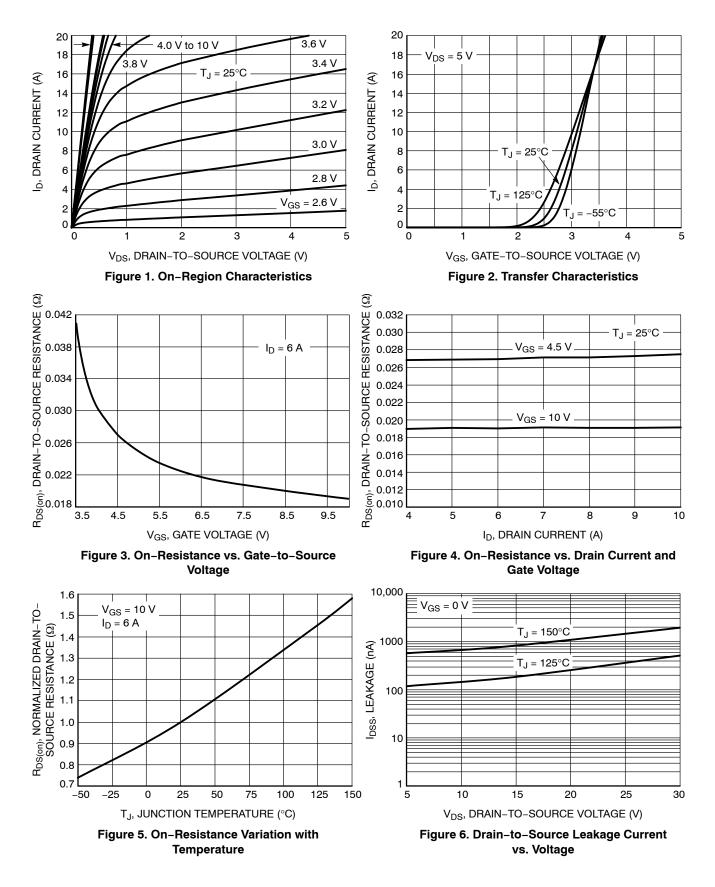
5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%. 6. Switching characteristics are independent of operating junction temperatures.

DEVICE ORDERING INFORMATION

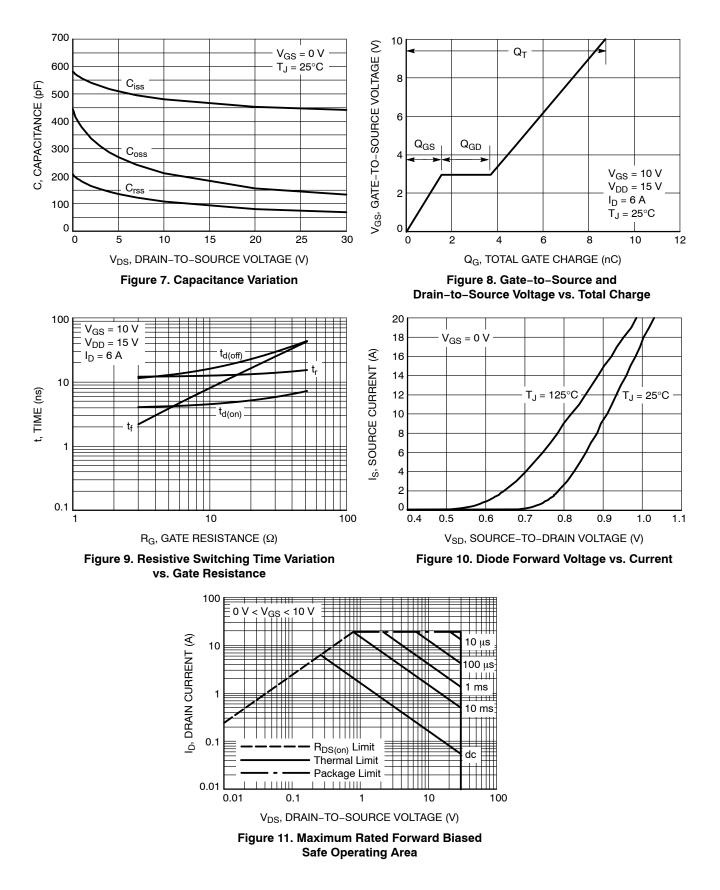
Device	Package	Shipping [†]
NTLUS4930NTAG	UDFN6 (Pb-Free)	3000 / Tape & Reel
NTLUS4930NTBG	UDFN6 (Pb-Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

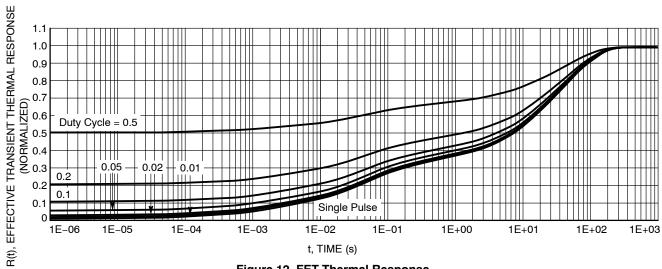
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

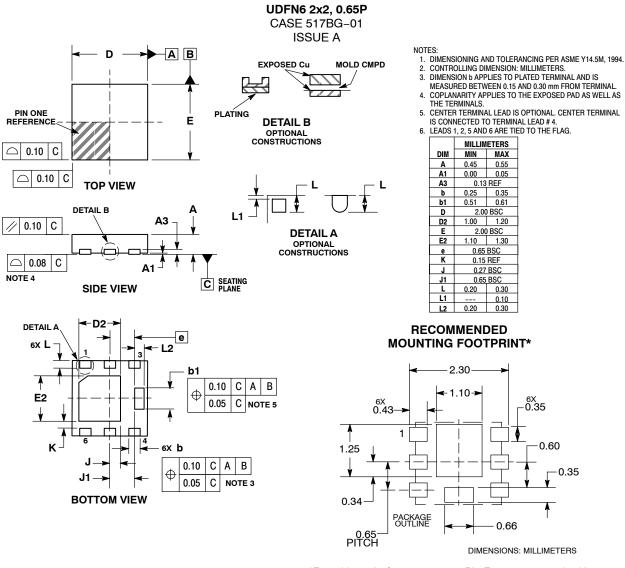


TYPICAL CHARACTERISTICS





PACKAGE DIMENSIONS



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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